

| Parameter | Symbol | Conditions | Values | | | Unit |
|-----------|--------|------------|--------|------|------|------|
| | | | min. | typ. | max. | |

Thermal characteristics

| | | | | | | | |
|--|----|------------|---|---|---|-----|-----|
| Thermal resistance, junction - case | Q1 | R_{thJC} | | - | - | 4.2 | K/W |
| | Q2 | | | - | - | 2.6 | |
| Thermal resistance, junction - ambient ¹⁾ | Q1 | R_{thJA} | 6 cm ² cooling area ²⁾ | - | - | 50 | |
| | Q2 | | | | | | |
| | Q1 | | minimal footprint, steady state ³⁾ | - | - | 125 | |
| | Q2 | | | | | | |

Electrical characteristics, at $T_j=25\text{ }^\circ\text{C}$, unless otherwise specified
Static characteristics

| | | | | | | | |
|---|----|---------------------|--|-----|-----|-----|---------------|
| Drain-source breakdown voltage | Q1 | $V_{(BR)DSS}$ | $V_{GS}=0\text{ V}, I_D=10\text{ mA}$ | 30 | - | - | V |
| | Q2 | | | | | | |
| Breakdown voltage temperature coefficient | Q1 | $dV_{(BR)DSS}/dT_j$ | $I_D=10\text{ mA}$, referenced to $25\text{ }^\circ\text{C}$ | - | 15 | - | mV/K |
| | Q2 | | | | | | |
| Gate threshold voltage | Q1 | $V_{GS(th)}$ | $V_{DS}=V_{GS}, I_D=250\text{ }\mu\text{A}$ | 1.2 | - | 2 | V |
| | Q2 | | | | | | |
| Zero gate voltage drain current | Q1 | I_{DSS} | $V_{DS}=24\text{ V}, V_{GS}=0\text{ V}, T_j=25\text{ }^\circ\text{C}$ | - | - | 1 | μA |
| | Q2 | | | | | 500 | |
| | Q1 | | $V_{DS}=24\text{ V}, V_{GS}=0\text{ V}, T_j=150\text{ }^\circ\text{C}$ | - | - | 0.1 | mA |
| | Q2 | | | | 3 | - | |
| Gate-source leakage current | Q1 | I_{GSS} | $V_{GS}=20\text{ V}, V_{DS}=0\text{ V}$ | - | - | 100 | nA |
| | Q2 | | | | | | |
| Drain-source on-state resistance | Q1 | $R_{DS(on)}$ | $V_{GS}=4.5\text{ V}, I_D=20\text{ A}$ | - | 5.4 | 7.0 | m Ω |
| | Q2 | | | | 3 | 3.7 | |
| | Q1 | | $V_{GS}=10\text{ V}, I_D=20\text{ A}$ | - | 3.8 | 5.0 | |
| | Q2 | | | | 2.1 | 2.8 | |
| Gate resistance | Q1 | R_G | | 1.3 | 2.6 | 5.2 | Ω |
| | Q2 | | | 0.5 | 0.9 | 1.8 | |
| Transconductance | Q1 | g_{fs} | $ V_{DS} >2 I_D R_{DS(on)max}, I_D=20\text{ A}$ | 32 | 65 | - | S |
| | Q2 | | | | 43 | 86 | |

| Parameter | Symbol | Conditions | Values | | | Unit |
|-----------|--------|------------|--------|------|------|------|
| | | | min. | typ. | max. | |

Dynamic characteristics

| | | | | | | | |
|------------------------------|----|--------------|--|---|------|------|----|
| Input capacitance | Q1 | C_{iss} | $V_{GS}=0\text{ V},$ $V_{DS}=15\text{ V}, f=1\text{ MHz}$ | - | 870 | 1160 | pF |
| | Q2 | | | - | 1500 | 2000 | |
| Output capacitance | Q1 | C_{oss} | | - | 330 | 439 | |
| | Q2 | | | - | 630 | 838 | |
| Reverse transfer capacitance | Q1 | C_{rss} | | - | 49 | - | |
| | Q2 | | | - | 88 | - | |
| Turn-on delay time | Q1 | $t_{d(on)}$ | $V_{DD}=15\text{ V},$ $V_{GS}=10\text{ V}, R_G=1.6\ \Omega,$ $I_D=20\text{ A}$ | - | 4.7 | - | ns |
| | Q2 | | | - | 4.1 | - | |
| Rise time | Q1 | t_r | | - | 3.8 | - | |
| | Q2 | | | - | 3.6 | - | |
| Turn-off delay time | Q1 | $t_{d(off)}$ | | - | 17 | - | |
| | Q2 | | | - | 19 | - | |
| Fall time | Q1 | t_f | | - | 3.0 | - | |
| | Q2 | | | - | 2.6 | - | |

Gate Charge Characteristics

| | | | | | | | | |
|-----------------------|----|---------------|--|---|-----|------|----|----|
| Gate to source charge | Q1 | Q_{gs} | $V_{DD}=15\text{ V},$ $I_D=30\text{ A},$ $V_{GS}=0\text{ to }4.5\text{ V}$ | - | 2.4 | 3.2 | nC | |
| Gate to drain charge | | Q_{gd} | | - | 2.2 | 2.9 | | |
| Gate charge total | | Q_g | | - | 6.7 | 10 | | |
| Gate plateau voltage | | $V_{plateau}$ | | - | 2.8 | - | | V |
| Gate to source charge | Q2 | Q_{gs} | | - | 4.0 | 5.3 | nC | |
| Gate to drain charge | | Q_{gd} | | - | 4.0 | 5.2 | | |
| Gate charge total | | Q_g | | - | 12 | 18.4 | | |
| Gate plateau voltage | | $V_{plateau}$ | | - | 2.6 | - | | V |
| Output charge | Q1 | Q_{oss} | | $V_{DD}=15\text{ V}, V_{GS}=0\text{ V}$ | - | 9 | 12 | nC |
| | Q2 | | | | - | 17 | 23 | |

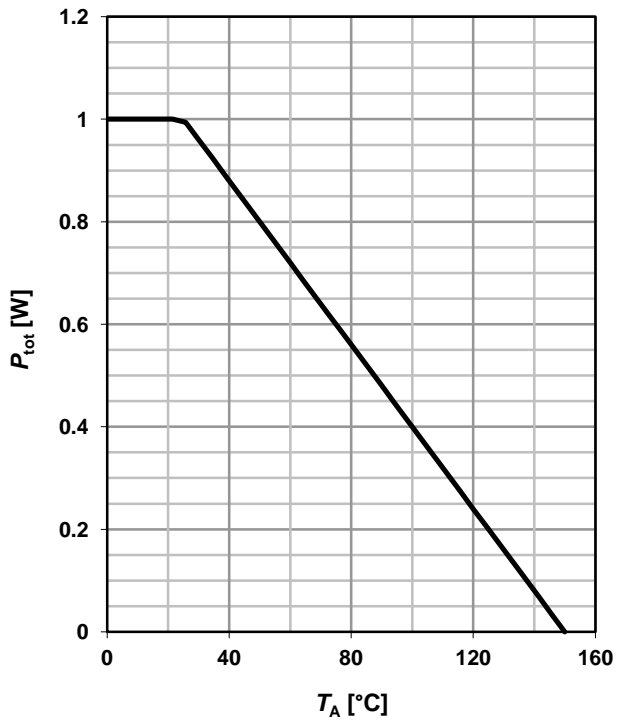
| Parameter | Symbol | Conditions | Values | | | Unit | |
|----------------------------------|--------|---------------|--|---|------|------|----|
| | | | min. | typ. | max. | | |
| Reverse Diode | | | | | | | |
| Diode continuous forward current | Q1 | I_S | $T_C=25\text{ °C}$ | - | - | 30 | A |
| | Q2 | | | | | 40 | |
| Diode pulse current | Q1 | $I_{S,pulse}$ | $T_C=25\text{ °C}$ | - | - | 160 | |
| | Q2 | | | - | - | 160 | |
| Diode forward voltage | Q1 | V_{SD} | $V_{GS}=0\text{ V}, I_F=20\text{ A}, T_j=25\text{ °C}$ | - | 0.9 | 1 | V |
| | Q2 | | | $V_{GS}=0\text{ V}, I_F=4\text{ A}, T_j=25\text{ °C}$ | - | 0.54 | |
| Reverse recovery charge | Q1 | Q_{rr} | $V_R=15\text{ V}, I_F=I_S, di_F/dt=100\text{ A}/\mu\text{s}$ | - | 5 | - | nC |
| | Q2 | | | - | 5 | - | |

²⁾ Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm² (one layer, 70 μm thick) copper area for drain connection. PCB is vertical in still air.

³⁾ device mounted on a minimum pad (one layer, 70 μm thick)

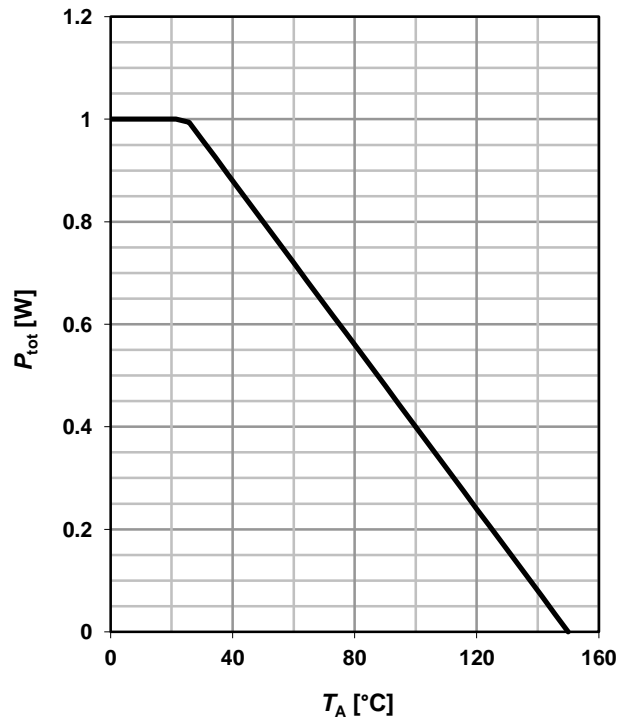
1 Power dissipation (Q1)

$$P_{\text{tot}} = f(T_A)^3$$



2 Power dissipation (Q2)

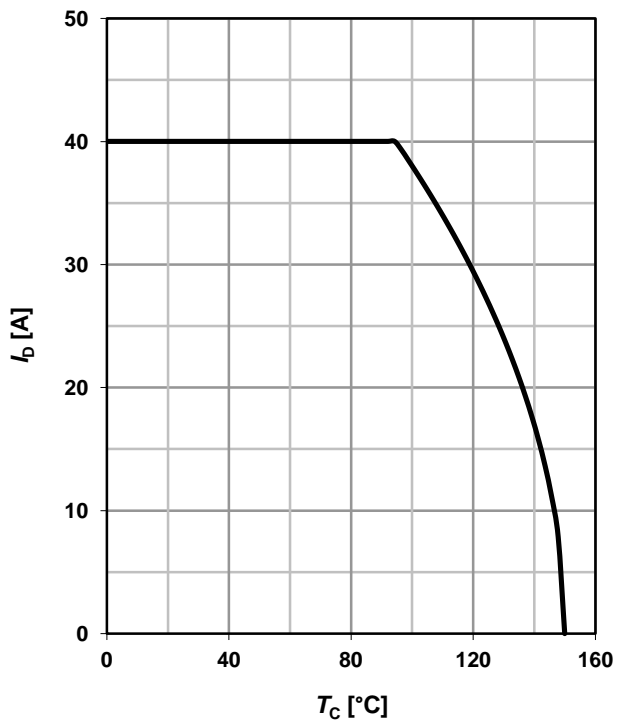
$$P_{\text{tot}} = f(T_A)^3$$



3 Drain current (Q1)

$$I_D = f(T_C)$$

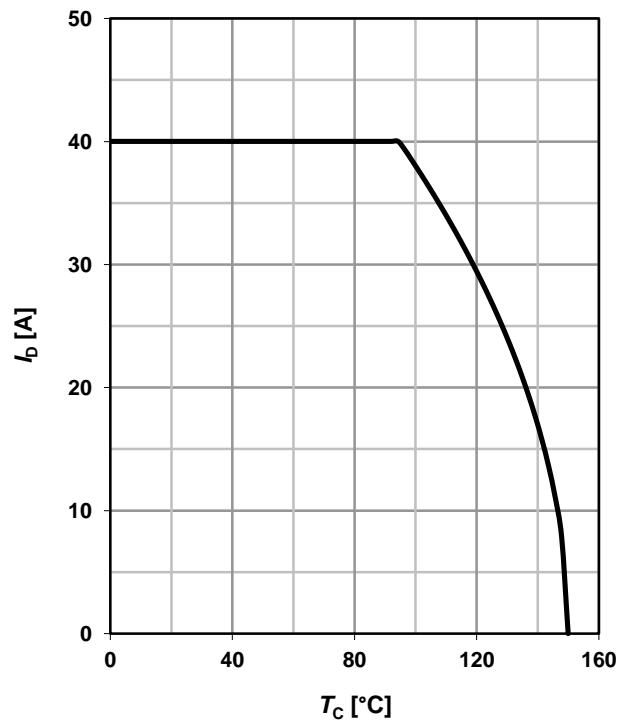
parameter: $V_{GS} \geq 10$ V



4 Drain current (Q2)

$$I_D = f(T_C)$$

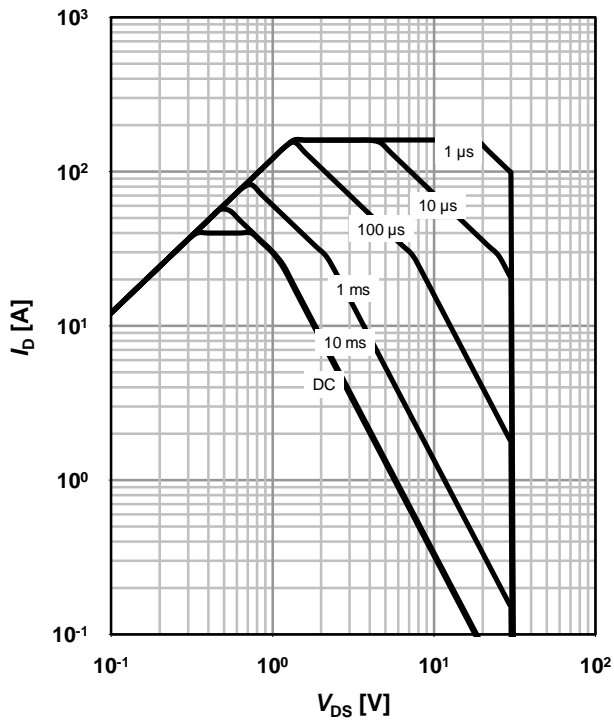
parameter: $V_{GS} \geq 10$ V



5 Safe operating area (Q1)

$I_D=f(V_{DS}); T_C=25\text{ }^\circ\text{C}; D=0$

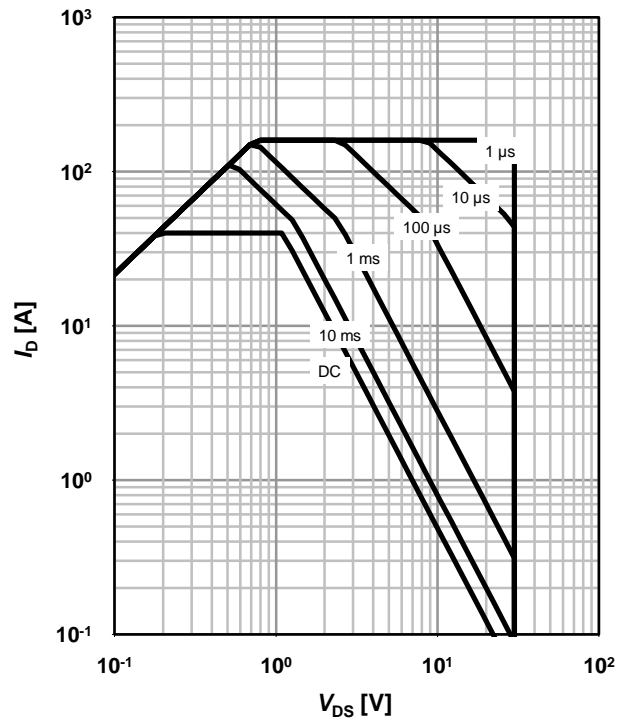
parameter: t_p



6 Safe operating area (Q2)

$I_D=f(V_{DS}); T_C=25\text{ }^\circ\text{C}; D=0$

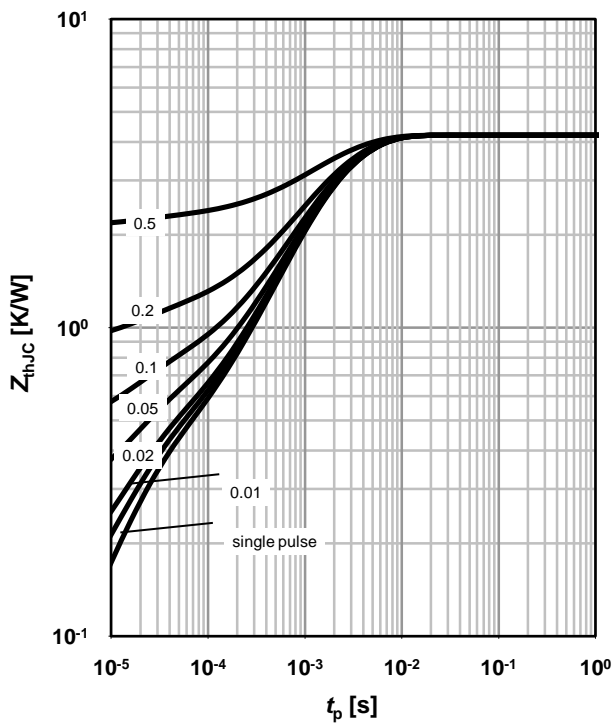
parameter: t_p



7 Max. transient thermal impedance (Q1)

$Z_{thJC}=f(t_p)$

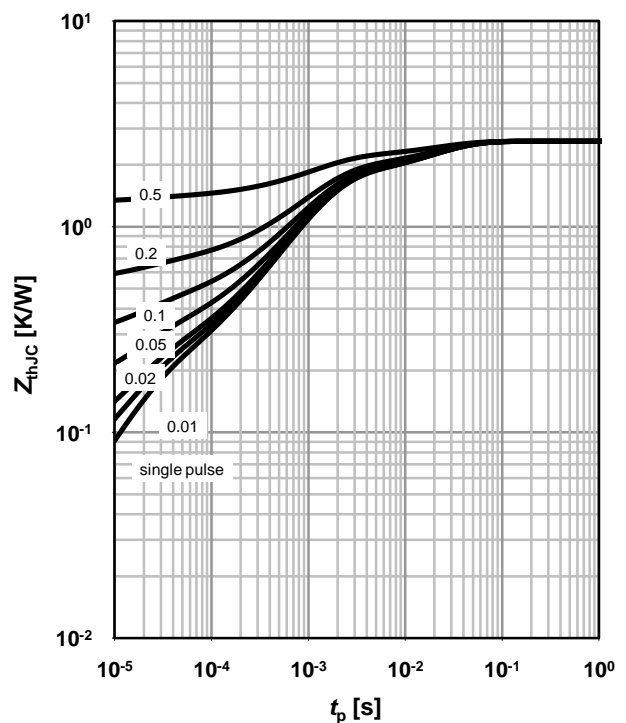
parameter: $D=t_p/T$



8 Max. transient thermal impedance (Q2)

$Z_{thJC}=f(t_p)$

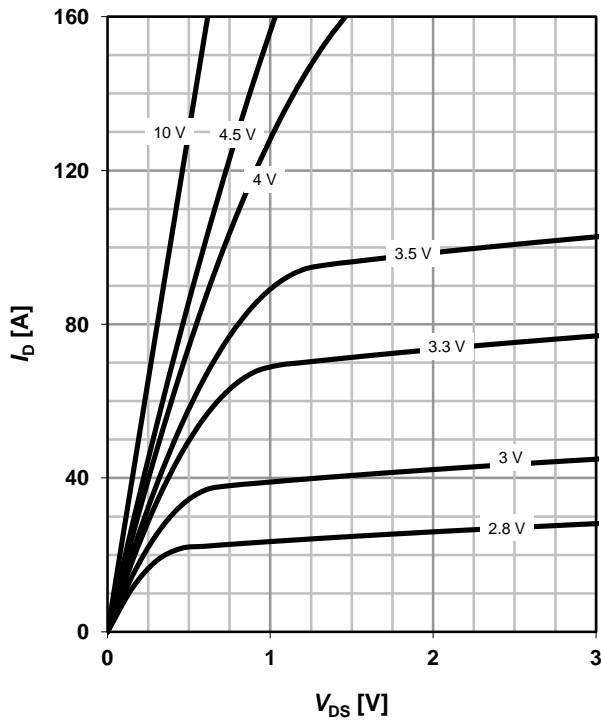
parameter: $D=t_p/T$



9 Typ. output characteristics (Q1)

$I_D=f(V_{DS}); T_j=25\text{ }^\circ\text{C}$

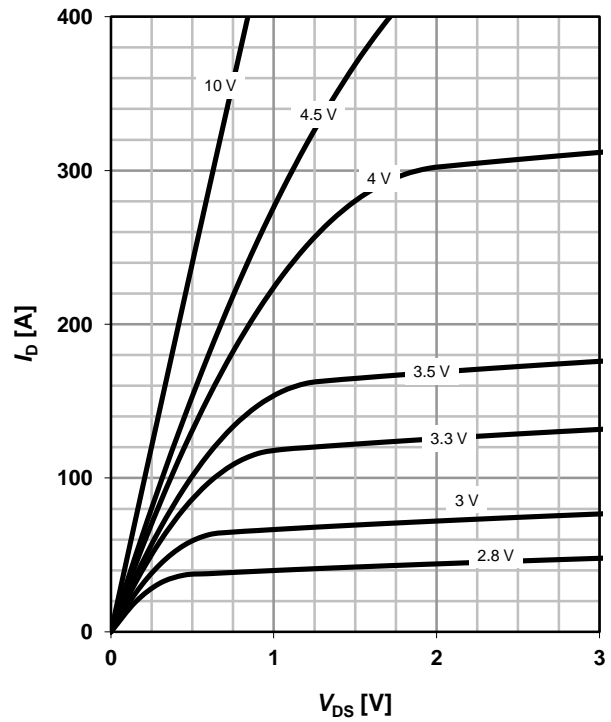
parameter: V_{GS}



10 Typ. output characteristics (Q2)

$I_D=f(V_{DS}); T_j=25\text{ }^\circ\text{C}$

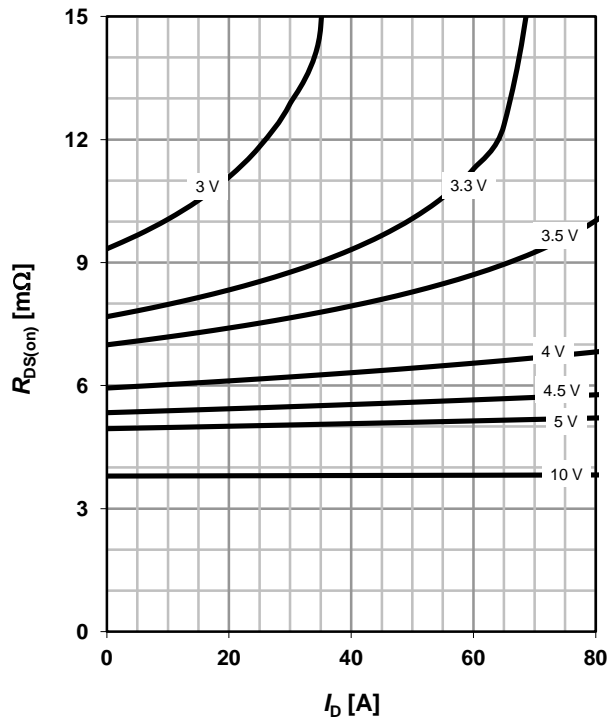
parameter: V_{GS}



11 Typ. drain-source on resistance (Q1)

$R_{DS(on)}=f(I_D); T_j=25\text{ }^\circ\text{C}$

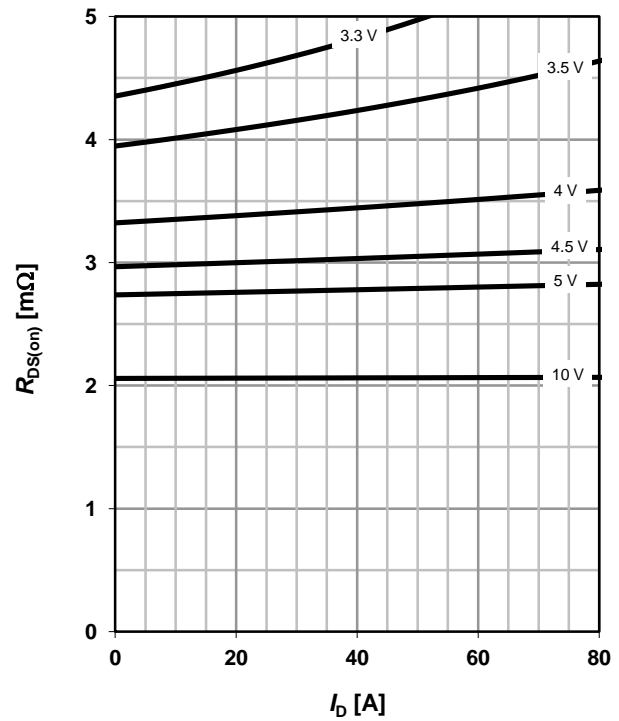
parameter: V_{GS}



12 Typ. drain-source on resistance (Q2)

$R_{DS(on)}=f(I_D); T_j=25\text{ }^\circ\text{C}$

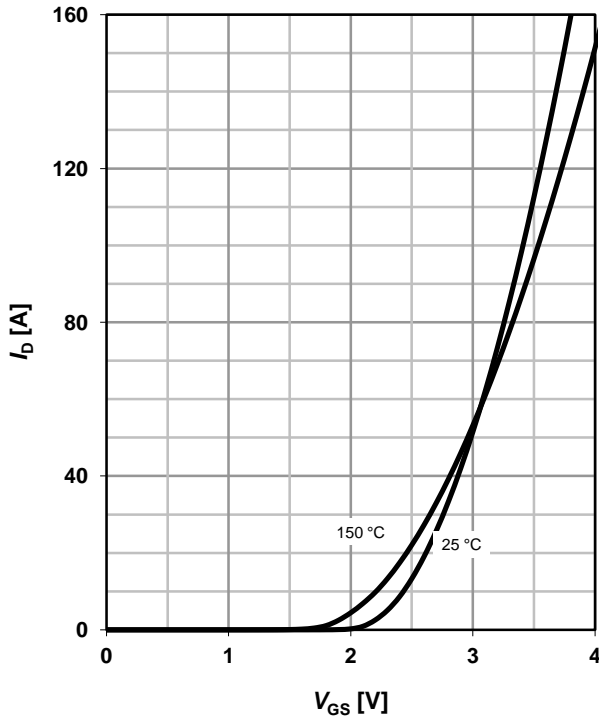
parameter: V_{GS}



13 Typ. transfer characteristics (Q1)

$$I_D = f(V_{GS}); |V_{DS}| > 2 |I_D| R_{DS(on)max}$$

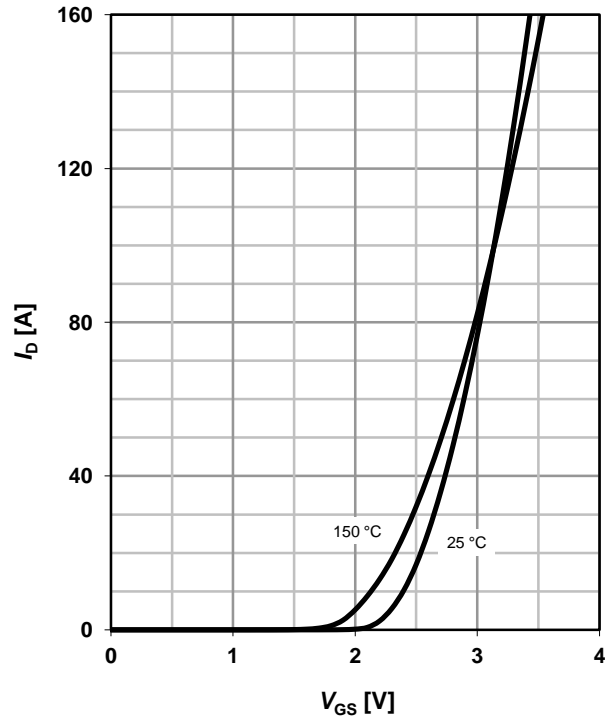
parameter: T_j



14 Typ. transfer characteristics (Q2)

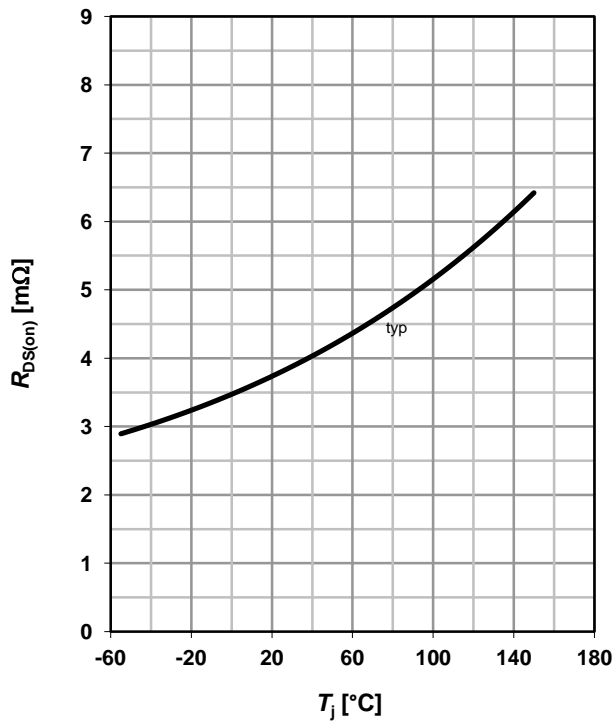
$$I_D = f(V_{GS}); |V_{DS}| > 2 |I_D| R_{DS(on)max}$$

parameter: T_j



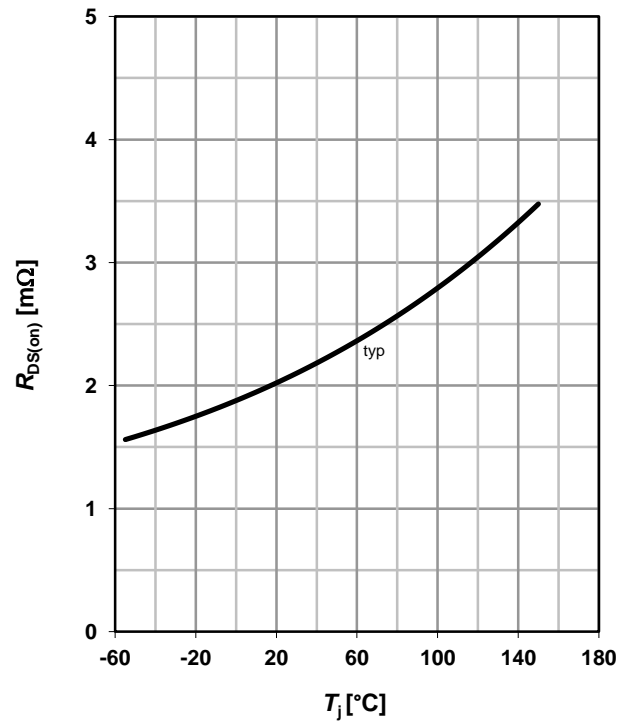
15 Drain-source on-state resistance (Q1)

$$R_{DS(on)} = f(T_j); I_D = 20 \text{ A}; V_{GS} = 10 \text{ V}$$



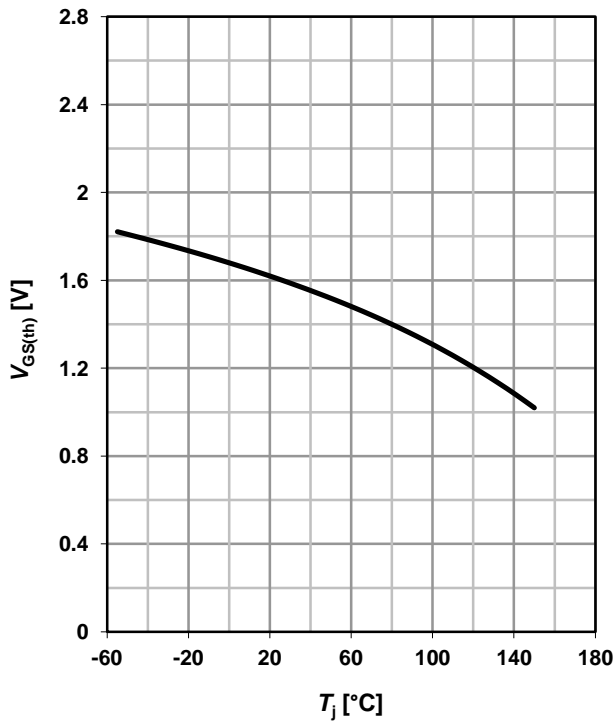
16 Drain-source on-state resistance (Q2)

$$R_{DS(on)} = f(T_j); I_D = 20 \text{ A}; V_{GS} = 10 \text{ V}$$



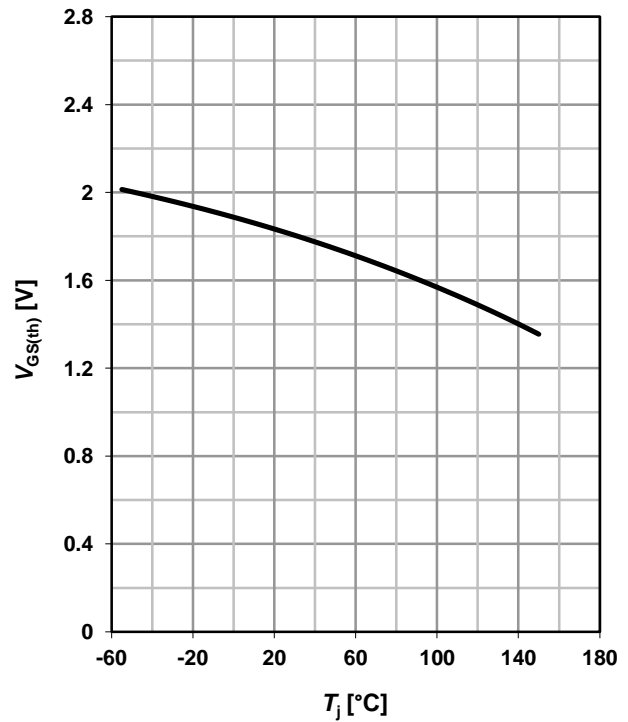
17 Typ. gate threshold voltage (Q1)

$V_{GS(th)}=f(T_j)$; $V_{GS}=V_{DS}$; $I_D=250 \mu A$



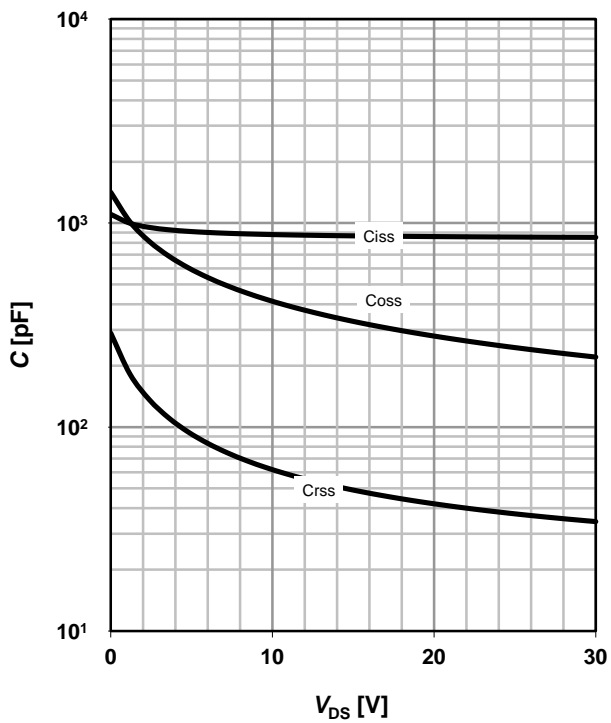
18 Typ. gate threshold voltage (Q2)

$V_{GS(th)}=f(T_j)$; $V_{GS}=V_{DS}$; $I_D=10 \text{ mA}$



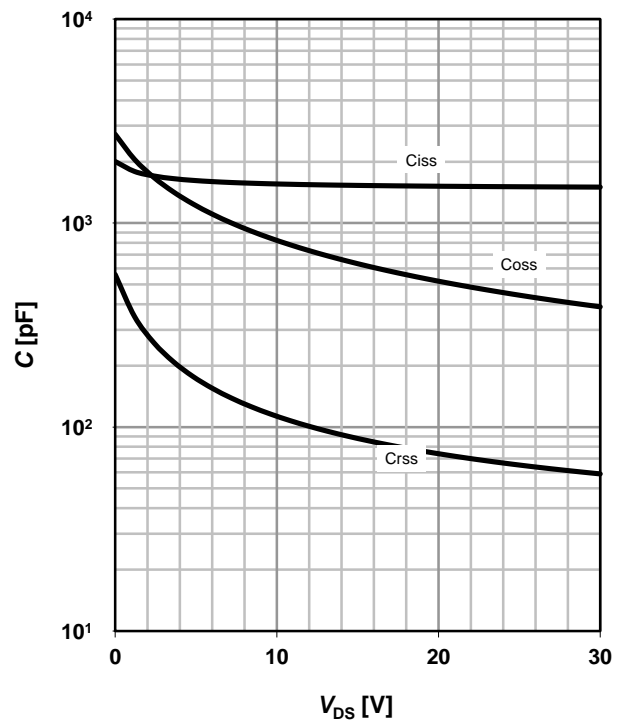
19 Typ. capacitances (Q1)

$C=f(V_{DS})$; $V_{GS}=0 \text{ V}$; $f=1 \text{ MHz}$



20 Typ. capacitances (Q2)

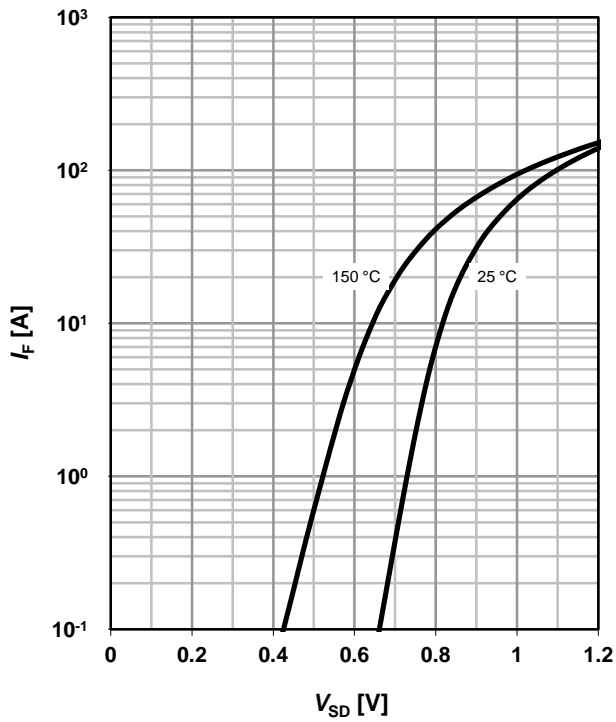
$C=f(V_{DS})$; $V_{GS}=0 \text{ V}$; $f=1 \text{ MHz}$



21 Forward characteristics of reverse diode (Q1)

$I_F=f(V_{SD})$

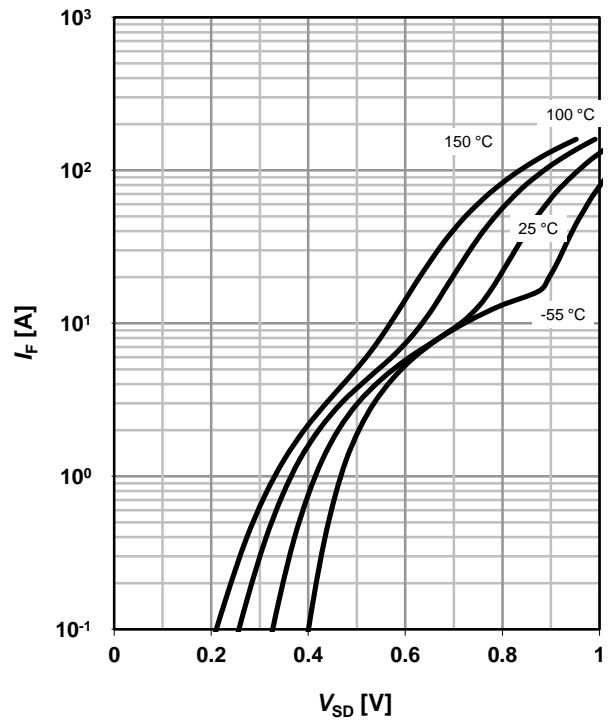
parameter: T_j



22 Forward characteristics of reverse diode (Q2)

$I_F=f(V_{SD})$

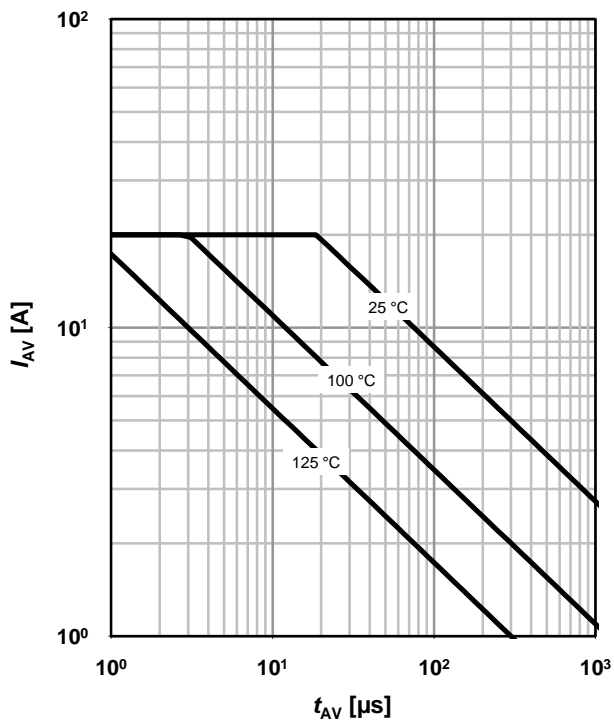
parameter: T_j



23 Avalanche characteristics (Q1)

$I_{AS}=f(t_{AV}); R_{GS}=25 \Omega$

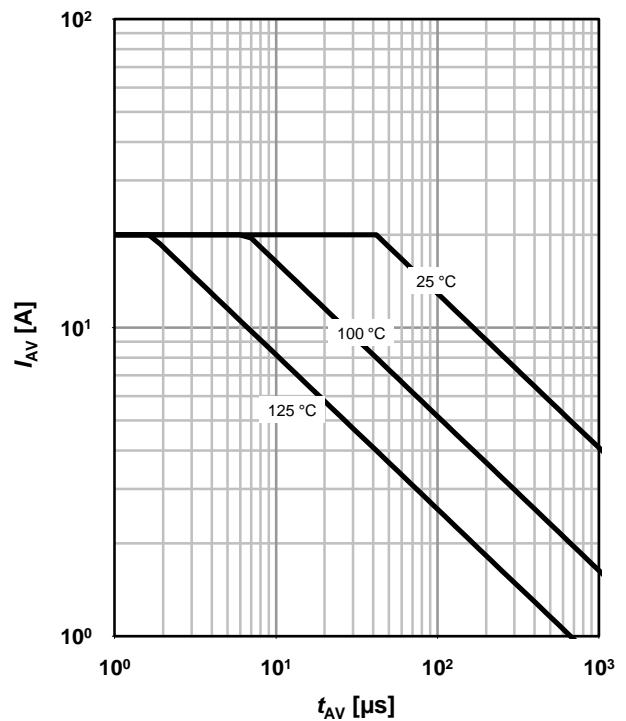
parameter: $T_{j(start)}$



24 Avalanche characteristics (Q2)

$I_{AS}=f(t_{AV}); R_{GS}=25 \Omega$

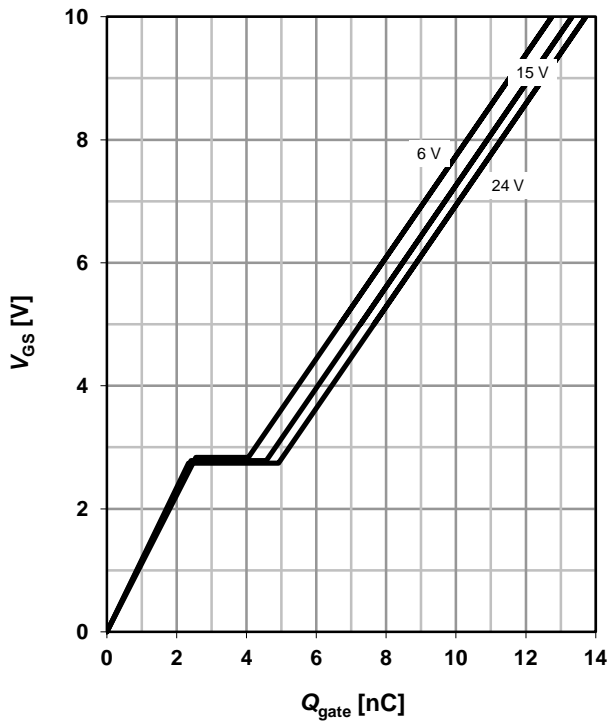
parameter: $T_{j(start)}$



25 Typ. gate charge (Q1)

$V_{GS}=f(Q_{gate}); I_D=20\text{ A pulsed}$

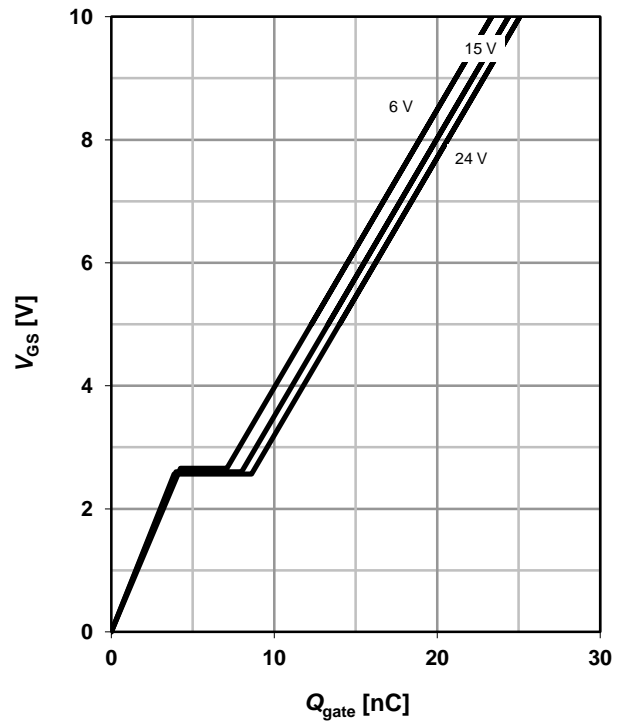
parameter: V_{DD}



26 Typ. gate charge (Q2)

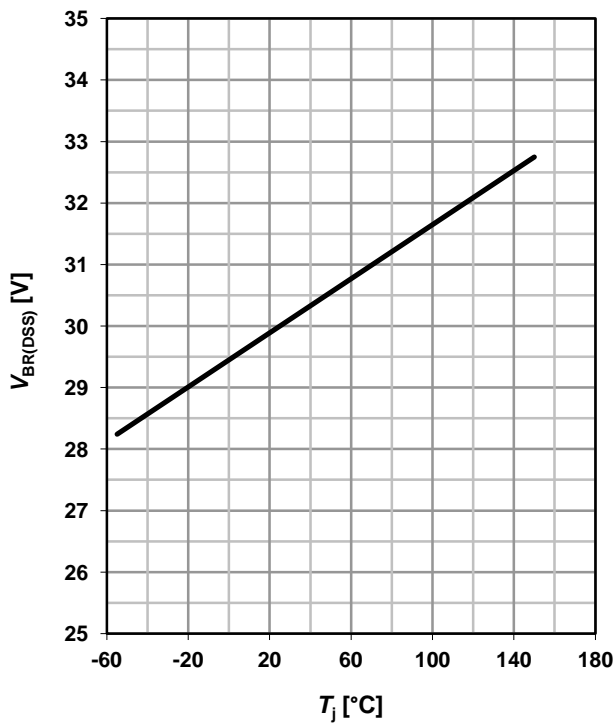
$V_{GS}=f(Q_{gate}); I_D=20\text{ A pulsed}$

parameter: V_{DD}



27 Drain-source breakdown voltage (Q1)

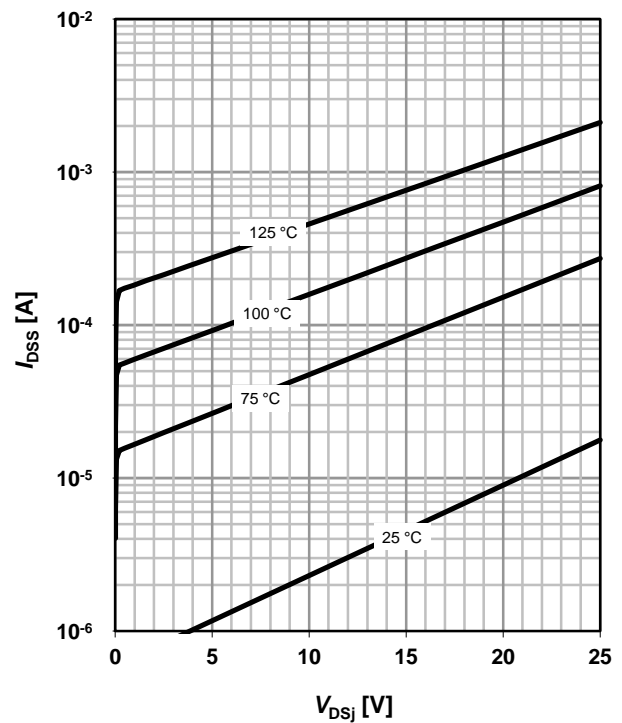
$V_{BR(DSS)}=f(T_j); I_D=1\text{ mA}$



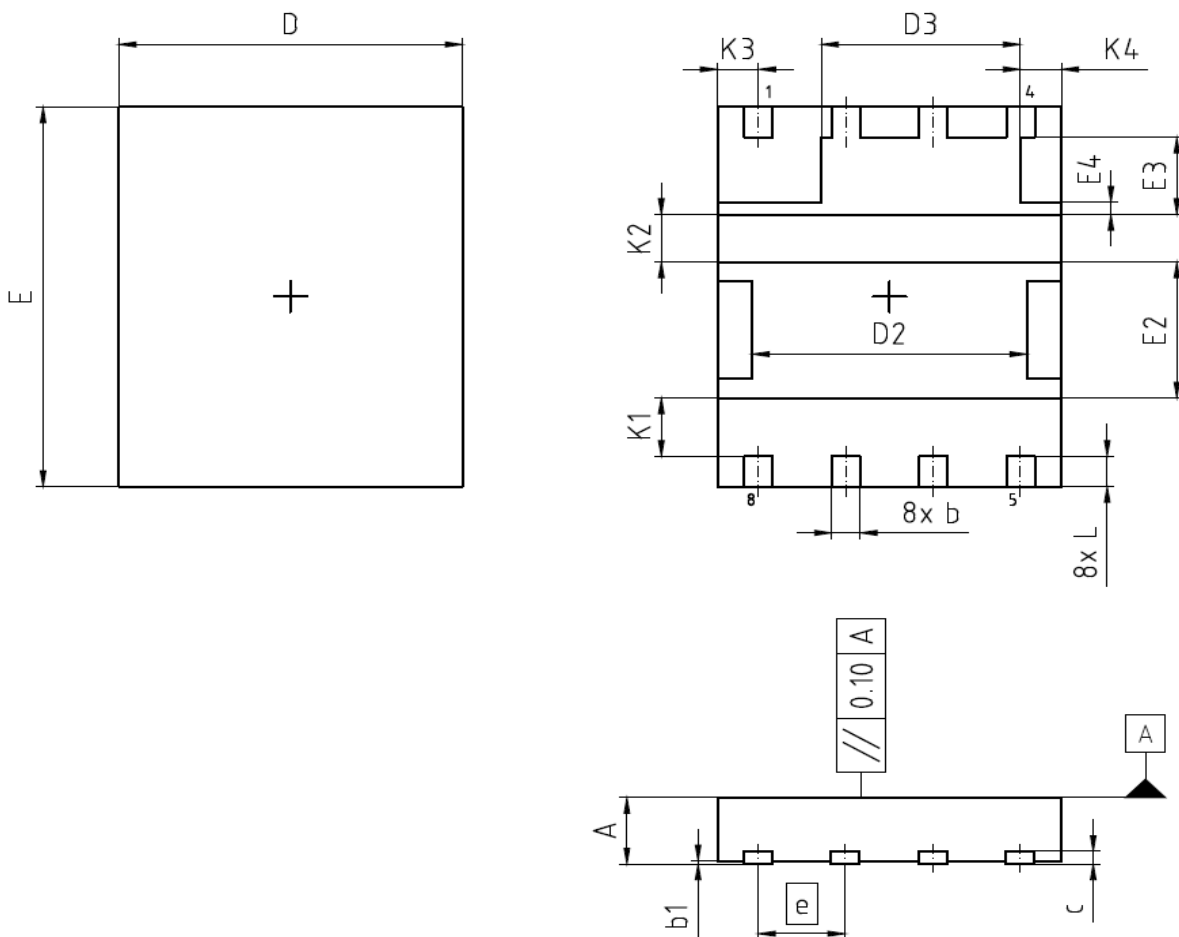
28 Typ. drain-source leakage current (Q2)

$I_{DSS}=f(V_{DS}); V_{GS}=0\text{ V}$

parameter: T_j



PG-TISON



| DIM | MILLIMETERS | | INCHES | |
|---------|-------------|------|------------|-------|
| | MIN | MAX | MIN | MAX |
| A | 0.90 | 1.15 | 0.035 | 0.045 |
| b | 0.31 | 0.51 | 0.012 | 0.020 |
| b1 | 0.00 | 0.05 | 0.000 | 0.002 |
| c | 0.10 | 0.30 | 0.004 | 0.012 |
| D | 4.90 | 5.10 | 0.193 | 0.201 |
| D2 | 3.90 | 4.10 | 0.154 | 0.161 |
| D3 | 2.80 | 3.00 | 0.110 | 0.118 |
| E | 5.90 | 6.10 | 0.232 | 0.240 |
| E2 | 2.05 | 2.25 | 0.081 | 0.089 |
| E3 | 1.12 | 1.32 | 0.044 | 0.052 |
| E4 | 0.10 | 0.30 | 0.004 | 0.012 |
| e | 1.27 (BSC) | | 0.05 (BSC) | |
| N | 8 | | 8 | |
| L | 0.38 | 0.58 | 0.015 | 0.023 |
| K1 | 0.82 | 1.02 | 0.032 | 0.040 |
| K2 | 0.65 | 0.85 | 0.026 | 0.033 |
| K3 = K4 | 0.50 | 0.70 | 0.019 | 0.027 |

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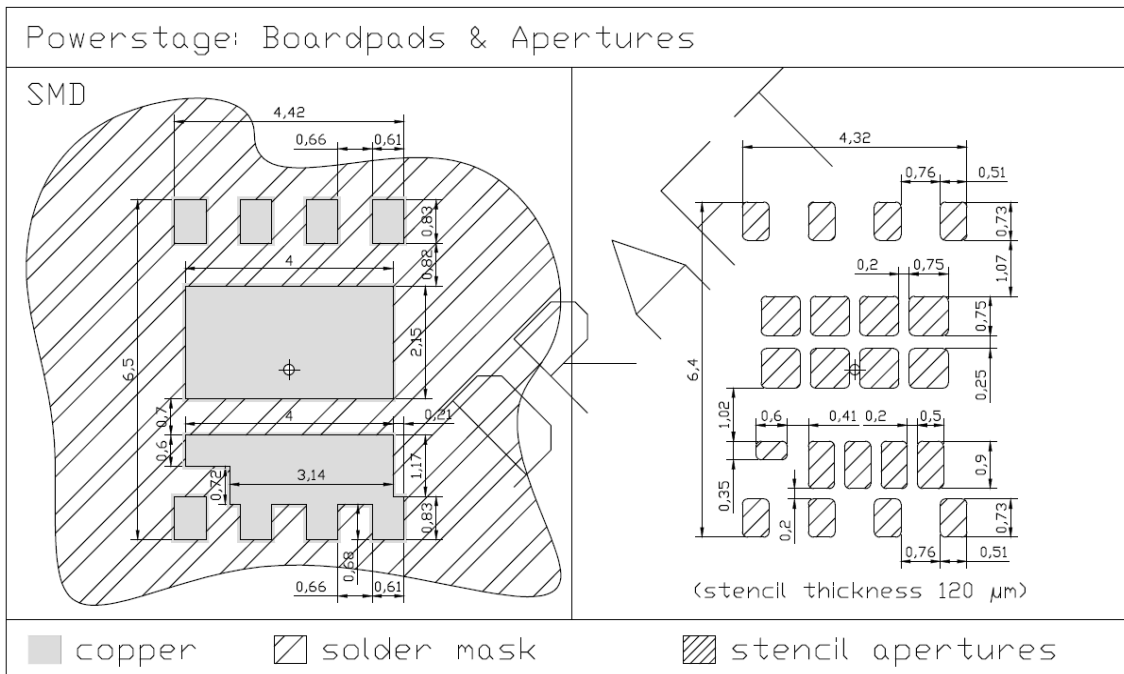
SCALE

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